

## Silicon Carbide Power MOSFET N-Channel Enhancement Mode

#### **Features**

- · Optimized package with separate driver source pin
- Lower profile TO-247-4 package body
- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Q,,)
- · Halogen free, RoHS compliant

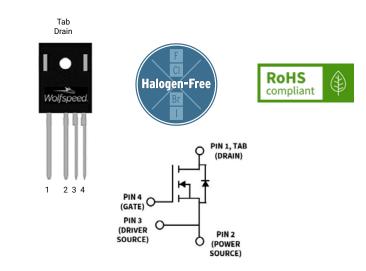
#### **Benefits**

- · Reduce switching losses and minimize gate ringing
- · Higher system efficiency
- · Reduce cooling requirements
- Increase power density
- · Increase system switching frequency

#### **Typical Applications**

- Motor Control
- · EV Battery Chargers
- High Voltage DC/DC Converters
- Solar/ESS
- UPS
- · Enterprise PSU

#### **Package**



Part Number	Package	Marking	
C3M0075120K1	T0-247-4L LP	C3M0075120K1	

## **Key Parameters**

Parameter	Symbol	Min.	Тур.	Max	Unit	Conditions	Note
Drain - Source Voltage	V <sub>DS</sub>			1200		T <sub>c</sub> = 25°C	
Maximum Gate - Source Voltage	V <sub>GS(max)</sub>	-8		+19	v	Transient	
Operational Gate-Source Voltage	V <sub>GS op</sub>		-4/15			Static	Note 1
				32		$V_{GS} = 15 \text{ V}, T_{C} = 25 \text{ °C}, T_{J} \le 175 \text{ °C}$	Fig. 19
DC Continuous Drain Current	l <sub>D</sub>			23	A	$V_{GS} = 15 \text{ V}, T_{C} = 100 \text{ °C}, T_{J} \le 175 \text{ °C}$	Note 2
Pulsed Drain Current	I <sub>DM</sub>			80		t <sub>Pmax</sub> limited by T <sub>jmax</sub> V <sub>GS</sub> = 15V, T <sub>C</sub> = 25 °C	Fig. 22
Power Dissipation	P <sub>D</sub>			145	W	$T_{c} = 25 ^{\circ}  \text{C}, T_{J} = 175 ^{\circ} ^{\circ} ^{\circ}$	Fig. 20
Operating Junction and Storage Temperature	T <sub>J</sub> , T <sub>stg</sub>			-40 to +175	°C		
Solder Temperature	T <sub>L</sub>			260		According to JEDEC J-STD-020	
Mounting Torque	M <sub>D</sub>			1 8.8	Nm lbf-in	M3 or 6-32 screw	

Note (1): Recommended turn-on gate voltage is 15V with ±5% regulation tolerance, see Application Note PRD-04814 for additional details Note (2): Verified by design

# **Electrical Characteristics** $(T_c = 25^{\circ}C \text{ unless otherwise specified})$

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	Note
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	1200			V	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 100 μA	
V	Gate Threshold Voltage	1.8	2.6	3.8	V	$V_{DS} = V_{GS}$ , $I_D = 5 \text{ mA}$	Fig. 11
$V_{GS(th)}$			2.1		٧	$V_{DS} = V_{GS}$ , $I_{D} = 5mA$ , $T_{J} = 175^{\circ}C$	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current		1	50	μΑ	V <sub>DS</sub> = 1200 V, V <sub>GS</sub> = 0 V	
$I_{GSS}$	Gate-Source Leakage Current		10	250	nA	V <sub>GS</sub> = 15 V, V <sub>DS</sub> = 0 V	
$R_{DS(on)}$	Drain-Source On-State Resistance		75	97.5	mΩ	V <sub>GS</sub> = 15 V, I <sub>D</sub> = 17.9 A	Fig. 4,
**DS(on)	Brain Godree on State Resistance		135		11152	V <sub>GS</sub> = 15 V, I <sub>D</sub> = 17.9 A, T <sub>J</sub> = 175°C	5, 6
$\mathbf{g}_{fs}$	Transconductance		11		S	V <sub>DS</sub> = 20 V, I <sub>DS</sub> = 17.9 A	Fig. 7
91s	Transconductance		10.5			V <sub>DS</sub> = 20 V, I <sub>DS</sub> = 17.9 A, T <sub>J</sub> = 175°C	1 ig. /
$C_{iss}$	Input Capacitance		1480				
$C_{\text{oss}}$	Output Capacitance		58		pF	$V_{GS} = 0 \text{ V}, V_{DS} = 0 \text{V to } 1000 \text{ V}$	Fig. 17, 18
$C_{rss}$	Reverse Transfer Capacitance		2.7			F = 1 MHz	
E <sub>oss</sub>	C <sub>oss</sub> Stored Energy		32		μJ	Vac = 25 mV	Fig. 16
C <sub>o(er)</sub>	Effective Output Capacitance (Energy Related)		67		pF		Note: 3
$C_{o(tr)}$	Effective Output Capacitance (Time Related)		96		pF	$V_{GS} = 0 \text{ V, } V_{DS} = 0 800 \text{ V}$	
E <sub>on</sub>	Turn-On Switching Energy (External Diode)		280			V <sub>DS</sub> = 800 V, V <sub>GS</sub> = -4 V/15 V, I <sub>D</sub> = 20 A,	Fig. 26, 28
E <sub>OFF</sub>	Turn Off Switching Energy (External Diode)		56		μJ	$R_{G(ext)}$ = 2.5 Ω, L= 98 μH, $T_J$ = 175°C FWD = External SiC DIODE	
Eon	Turn-On Switching Energy (Body Diode FWD)		280			$V_{DS}$ = 800 V, $V_{GS}$ = -4 V/15 V, $I_{D}$ = 20 A,	
E <sub>OFF</sub>	Turn-Off Switching Energy (Body Diode FWD)		63		μJ	$R_{G(ext)}$ = 2.5 Ω, L= 156 μH, $T_J$ = 175°C FWD = Internal Body Diode	Fig. 26, 28
$t_{\text{d(on)}} \\$	Turn-On Delay Time		8				
t <sub>r</sub>	Rise Time		22			$V_{DD}$ = 800 V, $V_{GS}$ = -4 V/15 V $I_{D}$ = 20 A, $R_{G(ext)}$ = 2.5 $\Omega$ ,	
$t_{\text{d(off)}}$	Turn-Off Delay Time		29		ns	Timing relative to V <sub>DS</sub>	Fig. 27, 28
<b>t</b> f	Fall Time		11		1	Inductive load	
R <sub>G(int)</sub>	Internal Gate Resistance		9.0		Ω	f = 1 MHz, V <sub>AC</sub> = 25 mV	
$Q_{gs}$	Gate to Source Charge		17	1 1,		V - 900 V V - 4 V / 1 E V	
$Q_{\text{gd}}$	Gate to Drain Charge		18		nC	$V_{DS} = 800 \text{ V}, V_{GS} = -4 \text{ V}/15 \text{ V}$ $I_D = 17.9 \text{ A}$	Fig. 12
Qg	Total Gate Charge		55			Per IEC60747-8-4 pg 21	

Note (3): C<sub>o(er)</sub>, a lumped capacitance that gives same stored energy as Coss while Vds is rising from 0 to 800V C<sub>o(tr)</sub>, a lumped capacitance that gives same charging time as Coss while Vds is rising from 0 to 800V

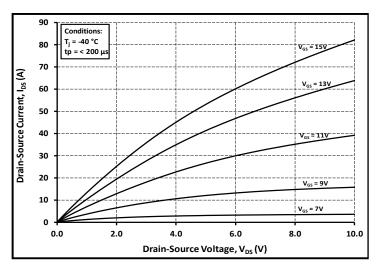
# **Reverse Diode Characteristics** (T<sub>c</sub> = 25°C unless otherwise specified)

Symbol	Parameter	Тур.	Max.	Unit	Test Conditions	Note
V	Diode Forward Voltage	4.8		٧	$V_{GS} = -4 \text{ V, } I_{SD} = 9 \text{ A, } T_{J} = 25 \text{ °C}$	Fig. 8, 9, 10
$V_{SD}$		4.2		٧	V <sub>GS</sub> = -4 V, I <sub>SD</sub> = 9 A, T <sub>J</sub> = 175 °C	
Is	Continuous Diode Forward Current		27	Α	$V_{GS} = -4 \text{ V, } T_{C} = 25^{\circ}\text{C}$	
Ізм	Diode pulse Current		80	Α	$V_{GS} = -4 \text{ V}$ , pulse width $t_p$ limited by $T_{jmax}$	
t <sub>rr</sub>	Reverse Recover time	20		ns		
Q <sub>rr</sub>	Reverse Recovery Charge	376		nC	$V_{GS} = -4 \text{ V, } I_{SD} = 20 \text{ A, } V_{R} = 800 \text{ V}$ dif/dt = 5280 A/µs, T <sub>J</sub> = 175 °C	
I <sub>rrm</sub>	Peak Reverse Recovery Current	25		Α	. J	
t <sub>rr</sub>	Reverse Recover time	28		ns		
Q <sub>rr</sub>	Reverse Recovery Charge	338		nC	V <sub>GS</sub> = -4 V, I <sub>SD</sub> = 20 A, V <sub>R</sub> = 800 V dif/dt = 1305 A/μs, Τ <sub>J</sub> = 175 °C	
l <sub>rrm</sub>	Peak Reverse Recovery Current	16		А	α, α	

## **Thermal Characteristics**

Symbol	Parameter	Тур.	Unit	Test Conditions	Note
$R_{ heta JC}$	Thermal Resistance from Junction to Case	0.88	°C/W		Fig. 21

# 4



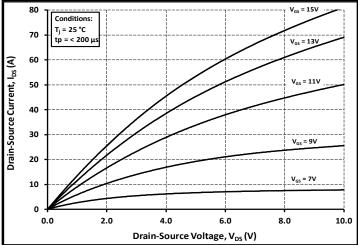
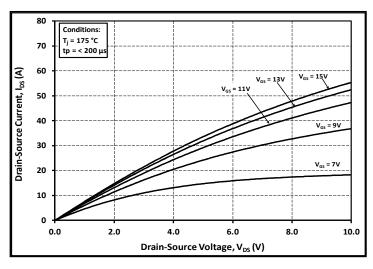


Figure 1. Output Characteristics  $T_J$  = -40 °C

Figure 2. Output Characteristics T<sub>J</sub> = 25 °C



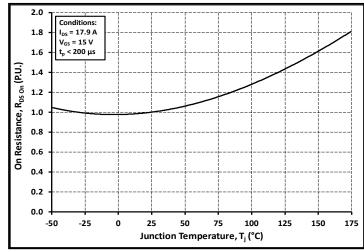
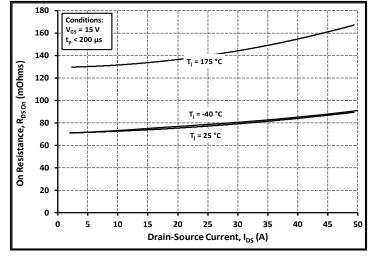


Figure 3. Output Characteristics T<sub>J</sub> = 175 °C

Figure 4. Normalized On-Resistance vs. Temperature



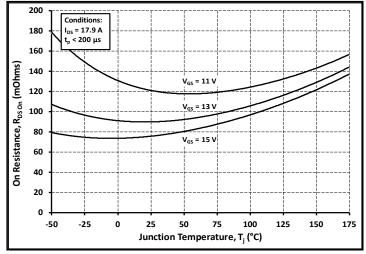


Figure 5. On-Resistance vs. Drain Current For Various Temperatures

Figure 6. On-Resistance vs. Temperature For Various Gate Voltage

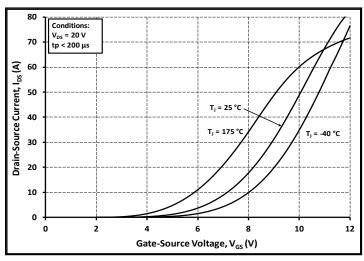


Figure 7. Transfer Characteristic for Various Junction Temperatures

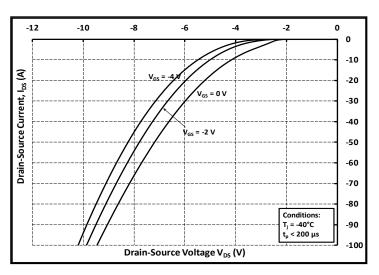


Figure 8. Body Diode Characteristic at -40 °C

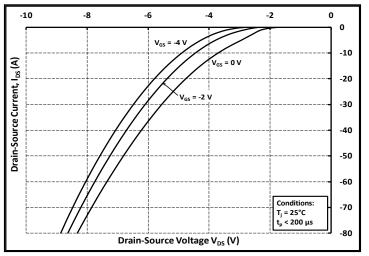


Figure 9. Body Diode Characteristic at 25 °C

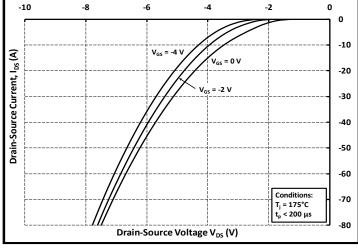


Figure 10. Body Diode Characteristic at 175 °C

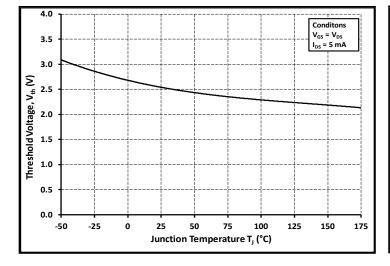


Figure 11. Threshold Voltage vs. Temperature

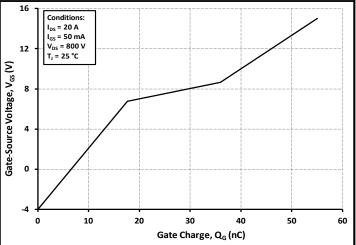
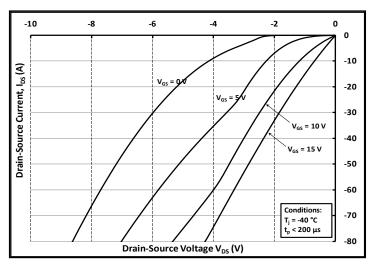


Figure 12. Gate Charge Characteristics





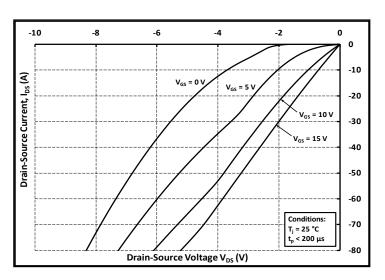


Figure 14. 3rd Quadrant Characteristic at 25 °C

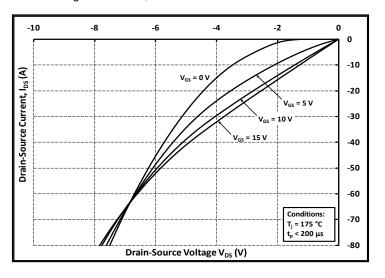


Figure 15. 3rd Quadrant Characteristic at 175 °C

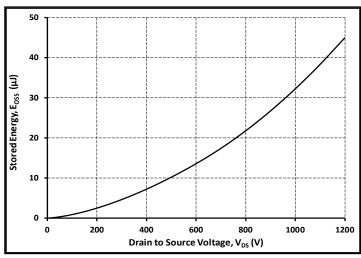


Figure 16. Output Capacitor Stored Energy

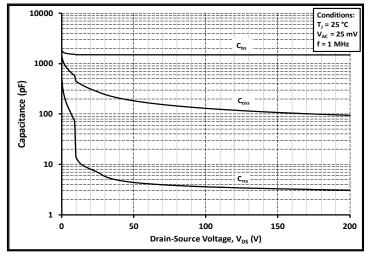


Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)

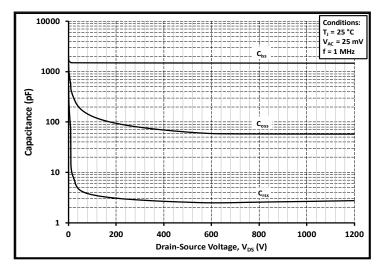
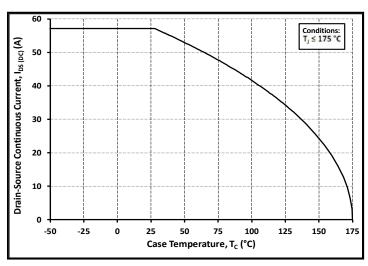


Figure 18. Capacitances vs. Drain-Source Voltage (0 - 1200V)



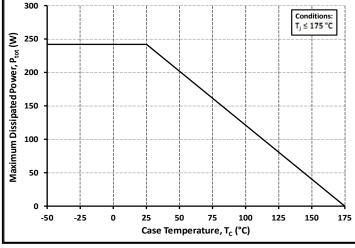
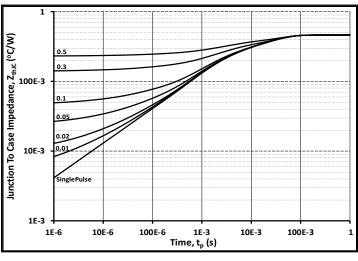


Figure 19. Continuous Drain Current Derating vs.

Case Temperature

Figure 20. Maximum Power Dissipation Derating vs.

Case Temperature



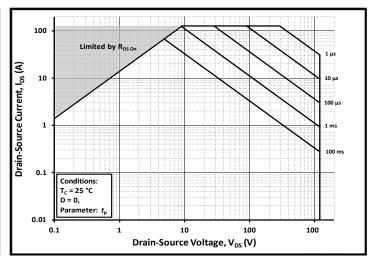
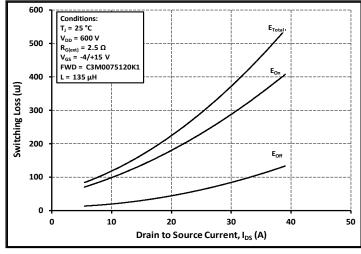


Figure 21. Transient Thermal Impedance (Junction - Case)

Figure 22. Safe Operating Area



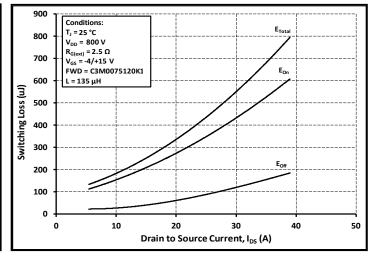


Figure 23. Clamped Inductive Switching Energy vs. Drain Current ( $V_{DD}$  = 600V)

Figure 24. Clamped Inductive Switching Energy vs. Drain Current ( $V_{DD}$  = 800V)

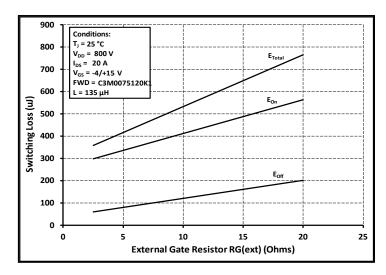


Figure 25. Clamped Inductive Switching Energy vs.  $R_{\text{G(ext)}}$ 

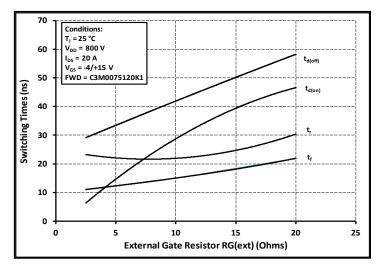


Figure 27. Switching Times vs.  $R_{G(ext)}$ 

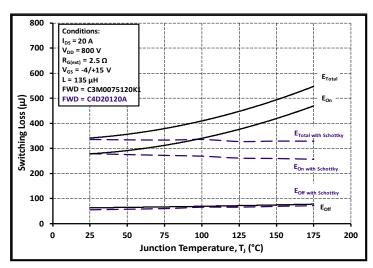


Figure 26. Clamped Inductive Switching Energy vs.
Temperature

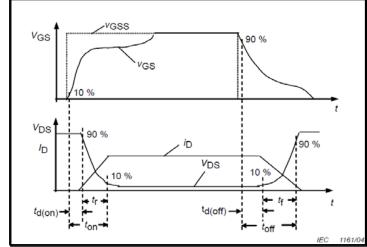


Figure 28. Switching Times Definition

9

# **Test Circuit Schematic**

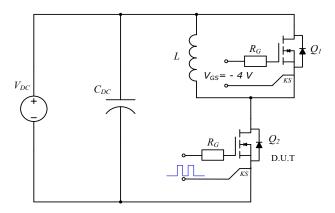
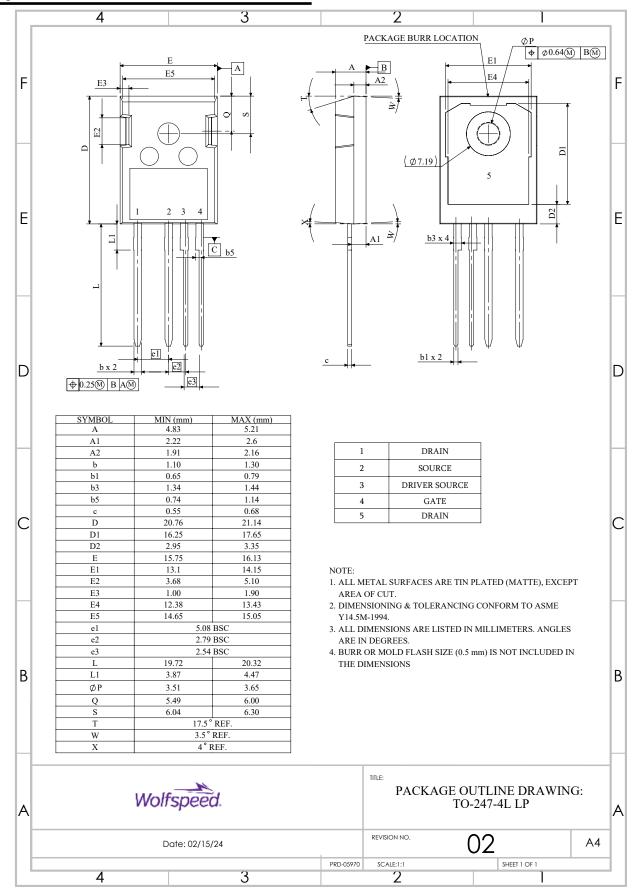


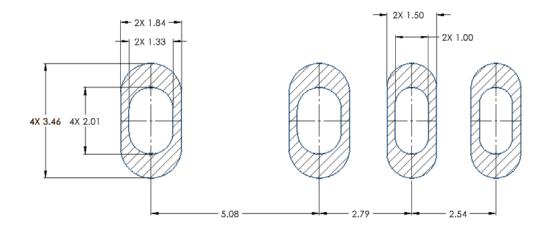
Figure 29. Clamped Inductive Switching Waveform Test Circuit

#### **Package Dimensions**



# **Recommended Solder Pad Layout**

All dimensions in mm



# Revision history

Document Version	Date of release	Descriptiion of changes
1.0	April-2024	Initial datasheet
2.0	October - 2024	Legal Disclaimer

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#### **Contact info:**

4600 Silicon Drive Durham, NC 27703 USA Tel: +1.919.313.5300 www.wolfspeed.com/power

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